

L Number	Hits	Search Text	DB	Time stamp
-	17	"resist application" with semiconductor with substrate	USPAT; US-PGPUB	2004/06/15 14:18
-	1	("resist application" with semiconductor with substrate) and hm	USPAT; US-PGPUB	2004/06/15 14:18
-	146	"resist application" with substrate	USPAT; US-PGPUB	2004/06/15 14:46
-	7	("resist application" with substrate) and hm	USPAT; US-PGPUB	2004/06/15 14:18
-	21944	(resist or photoresist or "photo resist") with (applicat\$4 or coat\$3) with (substrate or wafer)	USPAT; US-PGPUB	2004/06/15 14:47
-	924	((resist or photoresist or "photo resist") with (applicat\$4 or coat\$3) with (substrate or wafer)) and hm	USPAT; US-PGPUB	2004/06/15 14:47
-	4	((resist or photoresist or "photo resist") with (applicat\$4 or coat\$3) with (substrate or wafer)) and hm) and dehumidified	USPAT; US-PGPUB	2004/06/15 14:48
-	11	("5571560"   "5626913"   "5658615"   "5695817"   "5720814"   "5919520"   "5962070"   "5972426"   "6162507"   "6234692"   "6241403").PN.	USPAT	2004/06/16 08:29
-	3677	((427/240) or (427/314) or (427/444) or (438/782) or (438/780) or (438/905)).CCLS.	USPAT; US-PGPUB	2004/06/16 08:56
-	272	((427/240) or (427/314) or (427/444) or (438/782) or (438/780) or (438/905)).CCLS.) and ((pre or preliminary) with (treatment or treating or treated)) or "pre-treatment" or "pretreatment")	USPAT; US-PGPUB	2004/06/16 09:01
-	8	((427/240) or (427/314) or (427/444) or (438/782) or (438/780) or (438/905)).CCLS.) and ("de-humidified" or "dehumidified")	USPAT; US-PGPUB	2004/06/16 09:08
-	115	((427/240) or (427/314) or (427/444) or (438/782) or (438/780) or (438/905)).CCLS.) and (humidity with (control\$4 or reduc\$4))	USPAT; US-PGPUB	2004/06/16 09:09
-	11	((427/240) or (427/314) or (427/444) or (438/782) or (438/780) or (438/905)).CCLS.) and ((pre or preliminary) with (treatment or treating or treated)) or "pre-treatment" or "pretreatment")) and (((427/240) or (427/314) or (427/444) or (438/782) or (438/780) or (438/905)).CCLS.) and (humidity with (control\$4 or reduc\$4)))	USPAT; US-PGPUB	2004/06/16 09:09
-	3	("5143552"   "6306455"   "6326597"   "2001/0044161"   "2002/0025375").PN.	USPAT	2004/06/16 10:20
-	3	("5143552"   "6306455"   "6326597"   "2001/0044161"   "2002/0025375").PN.	USPAT	2004/06/21 09:38
-	2	(resist or "photoresist") with (dehumidified or "humidity control")	USPAT; US-PGPUB	2004/06/21 09:39
-	4	((resist or "photoresist") with (dehumidified or "humidity control")) and hm	USPAT; US-PGPUB	2004/06/21 09:40
-	17	(resist or "photoresist") with (dehumidified or "humidity control")	USPAT; US-PGPUB	2004/06/21 09:44
-	2	(resist or "photoresist") with (dehumidified or "humidity control")	EPO; JPO	2004/06/21 09:46
-	13	(resist or "photoresist") and (dehumidified or "humidity control")	EPO; JPO	2004/06/21 09:46
-	11	("5571560"   "5626913"   "5658615"   "5695817"   "5720814"   "5919520"   "5962070"   "5972426"   "6162507"   "6234692"   "6241403").PN.	USPAT	2004/06/21 10:05
-	0	6458208.URPN.	USPAT	2004/06/21 10:26